

[illegible]

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APPLN. SERIAL NO.
09/989,462

APPLICANT(S)
Han Kyoung CHO

FILING DATE
11/21/2001

**GROUP
2614**

U.S. PATENT DOCUMENTS

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U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS

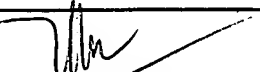
U.S. PATENT APPLICATIONS

	*APPL. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
II	2000-270293.A	9/29/2000	Japan			AB	
II	10-042218.A	2/13/1998	Japan			AB	
II	10-503626.A	3/31/1998	Japan			AB	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

11	Japanese Office Action dated February 8, 2005	
EXAMINER		DATE CONSIDERED 5/30/05

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